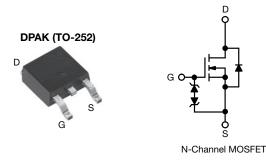
SiHD11N80AE

Vishay Siliconix



E Series Power MOSFET



PRODUCT SUMMARY		
V _{DS} (V) at T _J max.	85	50
R _{DS(on)} typ. (Ω) at 25 °C	$V_{GS} = 10 \text{ V}$	0.391
Q _g max. (nC)	4	2
Q _{gs} (nC)	e	3
Q _{gd} (nC)	1	2
Configuration	Sin	gle

FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low effective capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)
- Integrated Zener diode ESD protection
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- · Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy

ORDERING INFORMATION	
Package	DPAK (TO-252)
	SiHD11N80AE-GE3
Lead (Pb)-free and halogen-free	SiHD11N80AE-T1-GE3
	SiHD11N80AE-T4-GE3

ABSOLUTE MAXIMUM RATINGS	(T _C = 25 °C, un	less otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V _{DS}	800	V
Gate-source voltage			V _{GS}	± 30	v
Continuous drain aurrent (T 150 °C)	V at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	I	8	
Continuous drain current ($T_J = 150 \ ^{\circ}C$)	VGS AL TU V	T _C = 100 °C	۱ _D	5	А
Pulsed drain current ^a			I _{DM}	22	
Linear derating factor				0.6	W/°C
Single pulse avalanche energy ^b			E _{AS}	88	mJ
Maximum power dissipation			PD	78	W
Operating junction and storage temperature rar	nge		T _J , T _{stg}	-55 to +150	°C
Drain-source voltage slope		T _J = 125 °C	d\//dt	70	1//22
Reverse diode dV/dt ^d			dV/dt	2	V/ns
Soldering recommendations (peak temperature) c	For 10 s		260	°C

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature

b. $V_{DD} = 140$ V, starting $T_{J} = 25$ °C, L = 28.2 mH, $R_{g} = 25 \Omega$, $I_{AS} = 2.5$ A

c. 1.6 mm from case

d. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C

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Document Number: 92337





$\begin{tabular}{ c c c c c } \hline Static & & & & & & & & & & & & & & & & & & &$	PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
$\begin{array}{ c c c c c c } \hline Maximum junction-to-case (drain) & R_{thuC} & - & 1.6 \\ \hline \\ $	Maximum junction-to-ambient	R _{thJA}	-		62			°C / M	
$\begin{array}{ c c c c c c } \hline PARAMETER & SYMBOL & TEST CONDITIONS & MIN. & TYP. & MAX. & UNIT \\ \hline Static \\ \hline Drain-source breakdown voltage & V_{DS} & V_{GS} = 0 V, I_D = 250 \ \mu A & 800 & - & - & V \\ \hline O_S temperature coefficient & \Delta V_{DS}/T_J & Reference to 25 °C, I_D = 1 \ m A & - & 0.8 & - & V/^{\circ}C \\ \hline Gate-source threshold voltage (N) & V_{GS(th)} & V_{DS} = V_{GS}, I_D = 250 \ \mu A & 2 & - & 4 & V \\ \hline Gate-source threshold voltage (N) & V_{GS(th)} & V_{DS} = V_{GS}, I_D = 250 \ \mu A & 2 & - & 4 & V \\ \hline Gate-source leakage & I_{GSS} & V_{GS} = 30 V & - & - & \pm 10 \\ \hline V_{DS} = 400 \ V, V_{GS} = \pm 30 V & - & - & \pm 10 \\ \hline V_{DS} = 640 \ V, V_{GS} = 0 \ V, T_J = 125 \ ^{\circ}C & - & - & 10 \\ \hline Drain-source on-state resistance & R_{DS(on)} & V_{GS} = 10 \ V & I_D = 5.5 \ A & - & 0.391 & 0.450 \ \Omega \\ \hline Drain-source on-state resistance & C_{ISS} & V_{DS} = 30 \ V, I_D = 5.5 \ A & - & 2.9 \ - & S \\ \hline Dynamic & & & & & & & \\ \hline Dutu capacitance & C_{ISS} & & & & & & & \\ \hline Dutu capacitance & C_{ISS} & & & & & & & & & \\ \hline Dutu capacitance & C_{ISS} & & & & & & & & & & \\ \hline Dutput capacitance & C_{ISS} & & & & & & & & & \\ \hline Effective output capacitance, time & C_{o(tr)} & & & & & & & & & & \\ \hline Total gate charge & Q_g & & & & & & & & & & & & & & & \\ \hline Tum- on flag the mage & & & & & & & & & & & & & & & & & & &$	Maximum junction-to-case (drain)	R _{thJC}	-		1.6			-0/00	
$\begin{array}{ c c c c c c } \hline PARAMETER & SYMBOL & TEST CONDITIONS & MIN. & TYP. & MAX. & UNIT \\ \hline Static \\ \hline Drain-source breakdown voltage & V_{DS} & V_{GS} = 0 V, I_D = 250 \ \mu A & 800 & - & - & V \\ \hline O_S temperature coefficient & \Delta V_{DS}/T_J & Reference to 25 °C, I_D = 1 \ m A & - & 0.8 & - & V/^{\circ}C \\ \hline Gate-source threshold voltage (N) & V_{GS(th)} & V_{DS} = V_{GS}, I_D = 250 \ \mu A & 2 & - & 4 & V \\ \hline Gate-source threshold voltage (N) & V_{GS(th)} & V_{DS} = V_{GS}, I_D = 250 \ \mu A & 2 & - & 4 & V \\ \hline Gate-source leakage & I_{GSS} & V_{GS} = 30 V & - & - & \pm 10 \\ \hline V_{DS} = 400 \ V, V_{GS} = \pm 30 V & - & - & \pm 10 \\ \hline V_{DS} = 640 \ V, V_{GS} = 0 \ V, T_J = 125 \ ^{\circ}C & - & - & 10 \\ \hline Drain-source on-state resistance & R_{DS(on)} & V_{GS} = 10 \ V & I_D = 5.5 \ A & - & 0.391 & 0.450 \ \Omega \\ \hline Drain-source on-state resistance & C_{ISS} & V_{DS} = 30 \ V, I_D = 5.5 \ A & - & 2.9 \ - & S \\ \hline Dynamic & & & & & & & \\ \hline Dutu capacitance & C_{ISS} & & & & & & & \\ \hline Dutu capacitance & C_{ISS} & & & & & & & & & \\ \hline Dutu capacitance & C_{ISS} & & & & & & & & & & \\ \hline Dutput capacitance & C_{ISS} & & & & & & & & & \\ \hline Effective output capacitance, time & C_{o(tr)} & & & & & & & & & & \\ \hline Total gate charge & Q_g & & & & & & & & & & & & & & & \\ \hline Tum- on flag the mage & & & & & & & & & & & & & & & & & & &$									
	SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$,	unless otherwi	se noted)						
$\begin{array}{ c c c c c } \hline \mbox{Drain-source breakdown voltage} & V_{DS} & V_{DS} = 0 \ V, \ l_{D} = 250 \ \mu A & 800 & - & - & V \\ \hline V_{DS} \ temperature \ coefficient & \Delta V_{DS}/T_J & Reference \ to \ 25 \ ^{\circ}C, \ l_{D} = 1 \ m A & - & 0.8 & - & V/^{\circ}C \\ \hline \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNIT
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Static								
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-source breakdown voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 25	0 μΑ	800	-	-	V
$ \begin{array}{c c c c c c c c } Gate-source leakage & I_{GSS} & V_{GS} = \pm 20 & - & - & \pm 10 \\ \hline V_{GS} = \pm 30 & - & - & \pm 50 \\ \hline V_{GS} = \pm 30 & - & - & \pm 50 \\ \hline V_{GS} = \pm 30 & V & - & - & \pm 50 \\ \hline V_{DS} = 640 & V, V_{GS} = 0 & - & - & 10 \\ \hline V_{DS} = 640 & V, V_{GS} = 0 & V, T_J = 125 & - & - & 10 \\ \hline Prime related resistance & R_{DS(on)} & V_{GS} = 10 & V & I_D = 5.5 & - & - & 10 \\ \hline Prime related resistance & G_{rss} & V_{DS} = 30 & V, I_D = 5.5 & - & 2.9 & - & S \\ \hline Dynamic & & & & & & & & & & & & & & & & \\ \hline Prime related a & & & & & & & & & & & & & & & & & & $	V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _l	₀ = 1 mA	-	0.8	-	V/°C
$ \begin{array}{c c c c c c c c } Gate-source leakage & I_{GSS} & V_{GS} = \pm 20 & - & - & \pm 10 \\ \hline V_{GS} = \pm 30 & - & - & \pm 50 \\ \hline V_{GS} = \pm 30 & - & - & \pm 50 \\ \hline V_{GS} = \pm 30 & V & - & - & \pm 50 \\ \hline V_{DS} = 640 & V, V_{GS} = 0 & - & - & 10 \\ \hline V_{DS} = 640 & V, V_{GS} = 0 & V, T_J = 125 & - & - & 10 \\ \hline Prime related resistance & R_{DS(on)} & V_{GS} = 10 & V & I_D = 5.5 & - & - & 10 \\ \hline Prime related resistance & G_{rss} & V_{DS} = 30 & V, I_D = 5.5 & - & 2.9 & - & S \\ \hline Dynamic & & & & & & & & & & & & & & & & \\ \hline Prime related a & & & & & & & & & & & & & & & & & & $	Gate-source threshold voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 25	60 μA	2	-	4	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $,	$V_{GS} = \pm 20 V$		-	-	± 10	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-source leakage	IGSS	,	V _{GS} = ± 30 V		-	-	± 50	μΑ
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Zous anto unliterar dusia summent		V _{DS} =	= 800 V, V _{GS} =	= 0 V	-	-	1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero gate voltage drain current	IDSS	V _{DS} = 640 V, V _{GS} = 0 V, T _J = 125 °C		-	-	10		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-source on-state resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D =	= 5.5 A	-	0.391	0.450	Ω
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward transconductance ^a		V _{DS} :	= 30 V, I _D = 5	5.5 A	-	2.9	-	S
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic		•			•	•	•	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Input capacitance	C _{iss}	$V_{GS} = 0 V_{c}$		-	804	-		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Output capacitance	C _{oss}				-	34	-	1
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Reverse transfer capacitance	C _{rss}	f = 1 MHz		-	5	-	1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	1 1 7 00	C _{o(er)}		$V_{DS} = 0 V$ to 480 V, $V_{GS} = 0 V$		-	27	-	pF
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		C _{o(tr)}	$v_{\rm DS} = 0$			-	162	-	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Total gate charge	Qg				-	28	42	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-source charge	Q _{gs}	$V_{GS} = 10 V$	I _D = 5.5 A	, V _{DS} = 640 V	-	6	-	nC
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-drain charge		1			-	12	-	1
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-on delay time		1	•		-	13	26	
Turn-off delay time $t_{d(off)}$ $V_{GS} = 10 \text{ V}, \text{ R}_g = 9.1 \Omega$ -2550	Rise time		V _{DD} =	= 640 V, I _D = 5	5.5 A,	-	15	30	1
	Turn-off delay time	t _{d(off)}				-	25	50	ns
	Fall time		1			-	27	54	

f = 1 MHz, open drain

 $T_J=25~^\circ\text{C},~I_S=5.5~\text{A},~V_{GS}=0~\text{V}$

 $\begin{array}{l} T_{J}=25 \ ^{\circ}\text{C}, \ I_{F}=I_{S}=5.5 \ \text{A}, \\ \text{d}I/\text{d}t=100 \ \text{A}/\mu \text{s}, \ V_{R}=25 \ \text{V} \end{array}$

MOSFET symbol

showing the

integral reverse p - n junction diode 0.7

_

_

-

_

_

_

1.5

.

_

_

278

2.9

17

3

8

22

1.2

556

5.8

-

Ω

А

V

ns

μC

А

Notes

Gate input resistance

Drain-Source Body Diode Characteristics

Continuous source-drain diode current

Pulsed diode forward current

Diode forward voltage

Reverse recovery time

Reverse recovery charge

Reverse recovery current

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 V to 480 V V_{DSS}

Rg

 I_S

I_{SM}

V_{SD}

t_{rr}

Q_{rr}

I_{RRM}

b. C_{oss(tr)} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 V to 480 V V_{DSS}

2



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

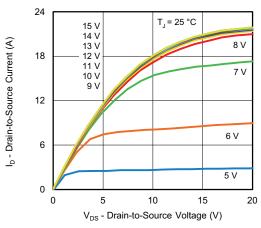


Fig. 1 - Typical Output Characteristics

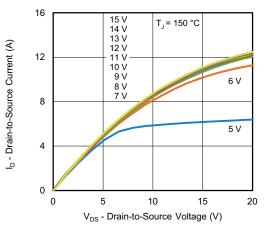


Fig. 2 - Typical Output Characteristics

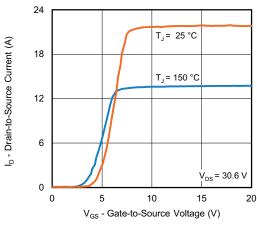


Fig. 3 - Typical Transfer Characteristics

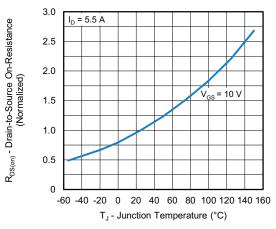


Fig. 4 - Normalized On-Resistance vs. Temperature

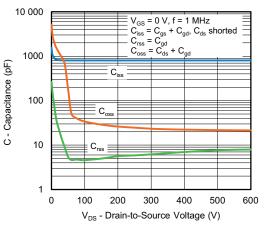
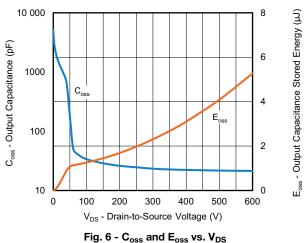


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



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SiHD11N80AE

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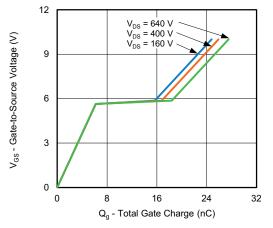


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

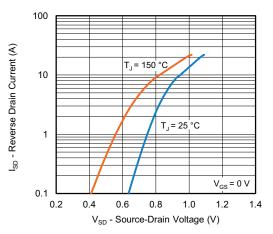


Fig. 8 - Typical Source-Drain Diode Forward Voltage

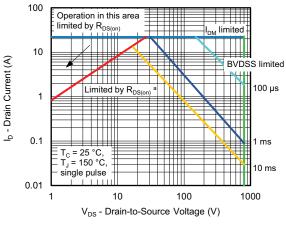


Fig. 9 - Maximum Safe Operating Area

Note

a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

4

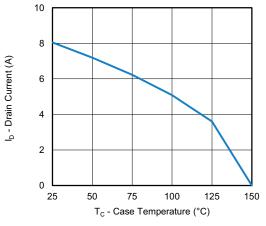


Fig. 10 - Maximum Drain Current vs. Case Temperature

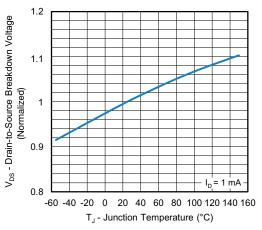
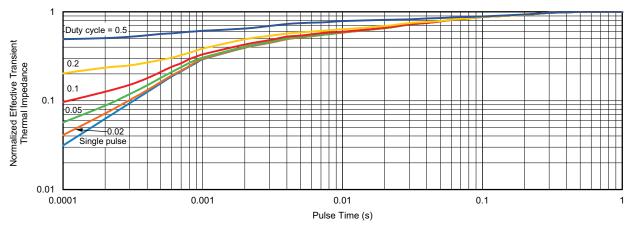


Fig. 11 - Temperature vs. Drain-to-Source Voltage



SiHD11N80AE

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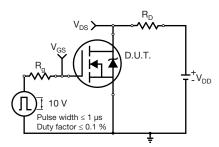


Fig. 13 - Switching Time Test Circuit

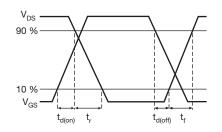


Fig. 14 - Switching Time Waveforms

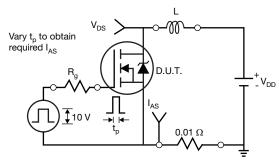


Fig. 15 - Unclamped Inductive Test Circuit

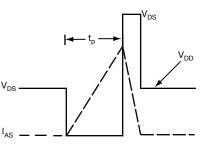


Fig. 16 - Unclamped Inductive Waveforms

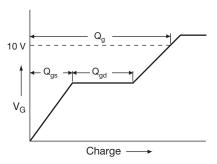


Fig. 17 - Basic Gate Charge Waveform

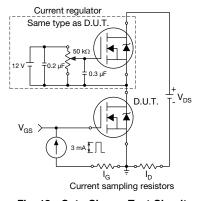


Fig. 18 - Gate Charge Test Circuit

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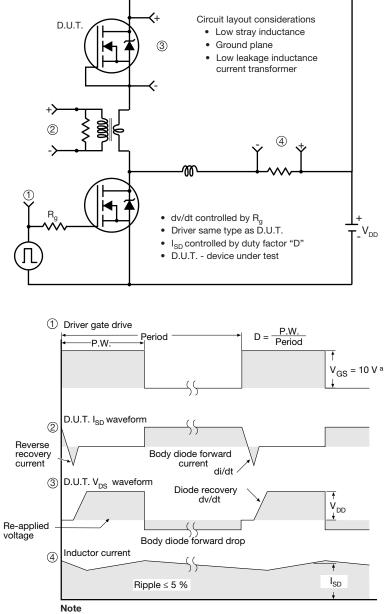
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Peak Diode Recovery dv/dt Test Circuit



a. $V_{GS} = 5$ V for logic level devices

Fig. 19 - For N-Channel

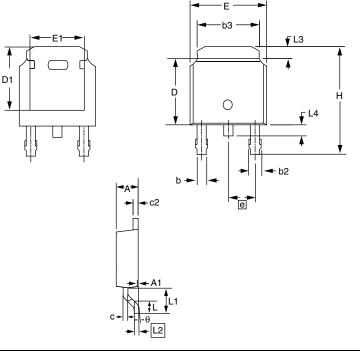
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Package Information

Vishay Siliconix

TO-252AA (HIGH VOLTAGE)



	MILLI	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
E	6.40	6.73	0.252	0.265	
L	1.40	1.77	0.055	0.070	
L1	2.74	3 REF	0.108 REF		
L2	0.508	3 BSC	0.020 BSC		
L3	0.89	1.27	0.035	0.050	
L4	0.64	1.01	0.025	0.040	
D	6.00	6.22	0.236	0.245	
Н	9.40	10.40	0.370	0.409	
b	0.64	0.88	0.025	0.035	
b2	0.77	1.14	0.030	0.045	
b3	5.21	5.46	0.205	0.215	
е	2.286	5 BSC	0.090 BSC		
А	2.20	2.38	0.087	0.094	
A1	0.00	0.13	0.000	0.005	
С	0.45	0.60	0.018	0.024	
c2	0.45	0.58	0.018	0.023	
D1	5.30	-	0.209	-	
E1	4.40	-	0.173	-	
θ	0'	10'	0'	10'	

Notes

1. Package body sizes exclude mold flash, protrusion or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 0.10 mm per side.

2. Package body sizes determined at the outermost extremes of the plastic body exclusive of mold flash, gate burrs and interlead flash, but including any mismatch between the top and bottom of the plastic body.

3. The package top may be smaller than the package bottom.

4. Dimension "b" does not include dambar protrusion. Allowable dambar protrusion shall be 0.10 mm total in excess of "b" dimension at maximum material condition. The dambar cannot be located on the lower radius of the foot.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)

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